

<b>Notice of References Cited</b>	Application/Control No. 09/639,551	Applicant(s)/Patent Under Reexamination LU, YOUHONG	
	Examiner John Pezzlo	Art Unit 2662	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2005/0186933 A1	08-2005	Trans, Francois	455/296
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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Application/Control No.

09/639,551

Applicant(s)/Patent Under  
Reexamination  
LU, YOUHONG

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John Pezzlo

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2662

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,055,310 A	04-2000	Zhang et al.	379/406.08
	B	US-6,049,607 A	04-2000	Marash et al.	379/406.08
	C	US-5,828,657 A	10-1998	Betts et al.	370/289
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
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	W	
	X	

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,434,110	08-2002	Hemkumar, Nariankadu D.	370/201
	B	US-4,970,715	11-1990	McMahan, Dennis B.	370/287
	C	US-6,347,141	02-2002	Klein et al.	379/406.08
	D	US-6,563,803	05-2003	Lee, Way-Shing	370/290
	E	US-6,560,332	05-2003	Christensson et al.	379/406.05
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP0310055A1	05-1989	EP	Vairvan	H04B 3/23
	O					
	P					
	Q					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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